Search Notes		
	EBIN IEBN BIBI	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/074,294	JENSEN ET AL.
Examiner	Art Unit
Kevin Y. Kim	2638

SEARCHED				
Class	Subclass	Date	Examiner	
375	355	6/21/05	Ilm	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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